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August 2011

# FGA70N33BTD **330V, 70A PDP IGBT**

#### **Features**

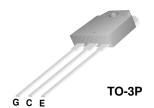
- · High current capability
- Low saturation voltage:  $V_{CE(sat)} = 1.7V @ I_C = 70A$
- · High input impedance
- · Fast switching
- · RoHS Compliant

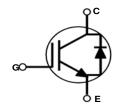
#### **Applications**

• PDP System

### **General Description**

Using Novel Trench IGBT Technology, Fairchild's new series of trench IGBTs offer the optimum performance for PDP applications where low conduction and switching losses are essential.





#### Absolute Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted

Symbol	Description		Ratings	Units
V <sub>CES</sub>	Collector to Emitter Voltage		330	V
V <sub>GES</sub>	Gate to Emitter Voltage		± 30	V
I <sub>Cpulse(1)</sub> *	Pulsed Collector Current @ T <sub>C</sub> = 25°C		160	А
I <sub>C pulse(2)</sub> *	Pulsed Collector Current @ T <sub>C</sub> = 25°C		220	А
P <sub>D</sub>	Maximum Power Dissipation @	$T_C = 25^{\circ}C$	149	W
. р	Maximum Power Dissipation @	$T_{\rm C} = 100^{\rm o}{\rm C}$	60	W
V <sub>RRM</sub>	Peak Repetitive Reverse Voltage of Diode		330	V
I <sub>F(AV)</sub>	Average Rectified Forward Current of diode @ T <sub>C</sub> = 100°C		10	Α
I <sub>FSM</sub>	Non-repetitive Peak Surge Current of diode 60Hz Single Half-Sine wave		100	Α
T <sub>J</sub> , T <sub>stg</sub>	Operating Junction Temperature and Storage Temperrature		-55 to +150	°C
T <sub>L</sub>	Maximum Lead Temp. for soldering Purposes, 1/8" from case for 5 seconds		300	°C

#### **Thermal Characteristics**

Symbol	Parameter	Тур.	Max.	Units
$R_{\theta JC}(IGBT)$	Thermal Resistance, Junction to Case		0.84	°C/W
$R_{\theta JC}(Diode)$	(Diode) Thermal Resistance, Junction to Case		1.16	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient		40	°C/W

1: Repetitive test , Pulse width=100usec , Duty=0.1

2: Half Sine Wave, D< 0.01, pluse width < 5usec
\*I<sub>C</sub>\_pulse limited by max Tj

# **Package Marking and Ordering Information**

			Packaging		Max Qty
<b>Device Marking</b>	Device	Package	Туре	Qty per Tube	per Box
FGA70N33BTD	FGA70N33BTDTU	TO-3P	Tube	30ea	

# Electrical Characteristics of the IGBT $T_C = 25^{\circ}\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Off Charac	teristics					
BV <sub>CES</sub>	Collector to Emitter Breakdown Voltage	$V_{GE} = 0V, I_{C} = 250\mu A$	330			V
ΔB <sub>VCES</sub> / ΔΤ <sub>J</sub>	Temperature Coefficient of Breakdown Voltage	V <sub>GE</sub> = 0V, I <sub>C</sub> = 250uA		0.3		V/°C
I <sub>CES</sub>	Collector Cut-Off Current	$V_{CE} = V_{CES}, V_{GE} = 0V$			250	μΑ
I <sub>GES</sub>	G-E Leakage Current	$V_{GE} = V_{GES}, V_{CE} = 0V$			±400	nA
On Charac	teristics					
V <sub>GE(th)</sub>	G-E Threshold Voltage	$I_C = 250 \mu A, V_{CE} = V_{GE}$	2.3	3.3	4.3	V
		I <sub>C</sub> = 20A, V <sub>GE</sub> = 15V		1.1		V
V "	Collector to Emitter Saturation Voltage	$I_C = 40A, V_{GE} = 15V,$		1.4		V
V <sub>CE(sat)</sub>	Concetor to Emitter Cataration Voltage	$I_C = 70A, V_{GE} = 15V, T_C = 25^{\circ}C$		1.7		V
		I <sub>C</sub> = 70A, V <sub>GE</sub> = 15V, T <sub>C</sub> = 125°C	1.8	1.8		V
Dynamic C	characteristics					
C <sub>ies</sub>	Input Capacitance	V 00V V 0V		1380		pF
C <sub>oes</sub>	Output Capacitance	V <sub>CE</sub> = 30V <sub>,</sub> V <sub>GE</sub> = 0V, f = 1MHz		140		pF
C <sub>res</sub>	Reverse Transfer Capacitance			60		pF
Switching	Characteristics					
t <sub>d(on)</sub>	Turn-On Delay Time			13		ns
t <sub>r</sub>	Rise Time	$V_{CC} = 200V, I_{C} = 20A,$		26		ns
t <sub>d(off)</sub>	Turn-Off Delay Time	$R_G = 5\Omega$ , $V_{GE} = 15V$ , Resistive Load, $T_C = 25^{\circ}C$		46		ns
t <sub>f</sub>	Fall Time			198		ns
t <sub>d(on)</sub>	Turn-On Delay Time			13		ns
t <sub>r</sub>	Rise Time	$V_{CC} = 200V, I_{C} = 20A,$ $R_{G} = 5\Omega, V_{GE} = 15V,$		28		ns
t <sub>d(off)</sub>	Turn-Off Delay Time	Resistive Load, $T_C = 125^{\circ}C$		48		ns
t <sub>f</sub>	Fall Time			268		ns
Q <sub>g</sub>	Total Gate Charge			49		nC
Q <sub>ge</sub>	Gate to Emitter Charge	$V_{CE} = 200V, I_{C} = 20A,$ $V_{GE} = 15V$		6.8		nC
Q <sub>gc</sub>	Gate to Collector Charge	*GE - 15*		17.5		nC

# Electrical Characteristics of the Diode $T_C = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Condition	าร	Min.	Тур.	Max	Units
V <sub>FM</sub>	Diode Forward Voltage	I <sub>F</sub> = 10A	$T_{\rm C} = 25^{\rm o}{\rm C}$		1.1	1.5	V
FINI	Blode i diward voltage		$T_{\rm C} = 125^{\rm o}{\rm C}$		0.95		]
t <sub>rr</sub>	Diode Reverse Recovery Time		$T_{\rm C} = 25^{\rm o}{\rm C}$		23		ns
rr	Blodd Heveled Headvery Hills		$T_{\rm C} = 125^{\rm o}{\rm C}$		36		
I <sub>rr</sub>	Diode Peak Reverse Recovery	I <sub>F</sub> =10A, dI/dt = 200A/μs	$T_{\rm C} = 25^{\rm o}{\rm C}$		2.8		Α
·rr	Current		$T_{\rm C} = 125^{\rm o}{\rm C}$		5.1		
Q <sub>rr</sub>	Diode Reverse Recovery Charge		$T_{\rm C} = 25^{\rm o}{\rm C}$		32		nC
~!!	2.000 No. 0.00 Noovery Charge		$T_{\rm C} = 125^{\rm o}{\rm C}$		91		]

**Figure 1. Typical Output Characteristics** 

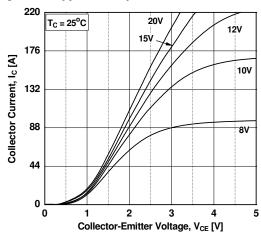


Figure 3. Typical Saturation Voltage Characteristics

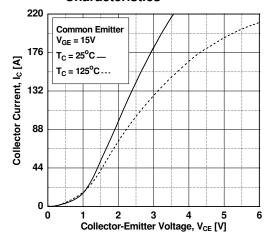
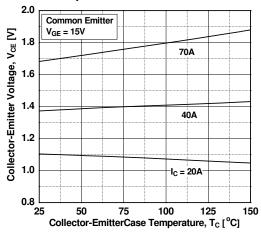


Figure 5. Saturation Voltage vs. Case
Temperature at Variant Current Level



**Figure 2. Typical Output Characteristics** 

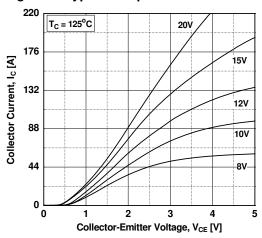


Figure 4. Transfer Characteristics

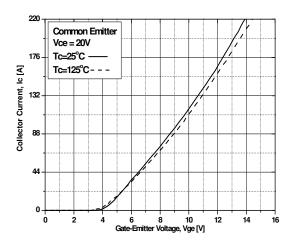


Figure 6. Saturation Voltage vs.  $V_{\text{GE}}$ 

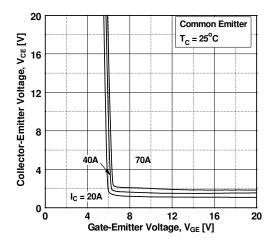
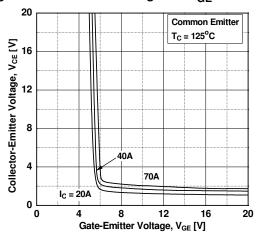


Figure 7. Saturation Voltage vs. V<sub>GE</sub>



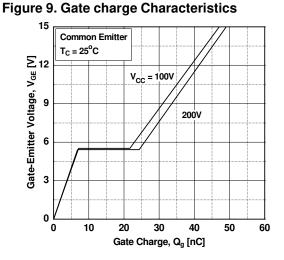


Figure 11. Turn-on Characteristics vs.
Gate Resistance

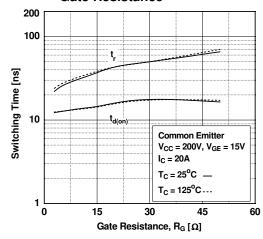


Figure 8. Capacitance Characteristics

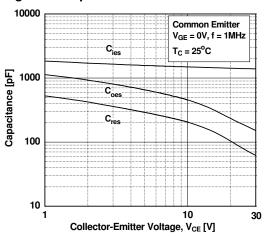


Figure 10. SOA Characteristics

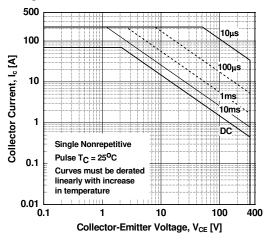


Figure 12. Turn-off Characteristics vs.
Gate Resistance

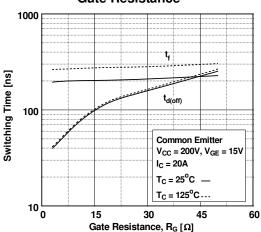


Figure 13. Turn-on Characteristics vs. Collector Current

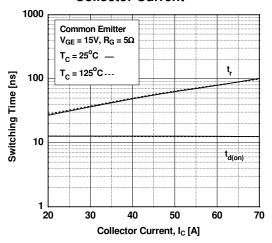


Figure 14. Turn-off Characteristics vs.
Collector Current

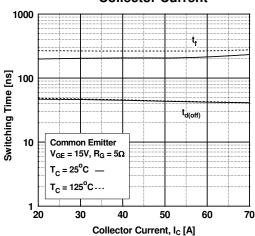


Figure 15. Switching Loss vs. Gate Resistance

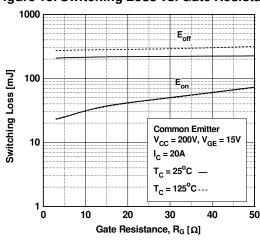


Figure 16. Switching Loss vs. Collector Current

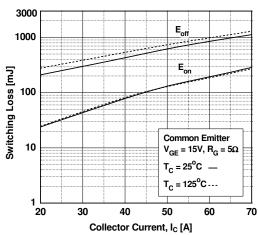
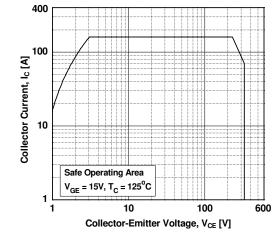


Figure 17. Turn off Switching SOA Characteristics Figure 18. Forward Characteristics



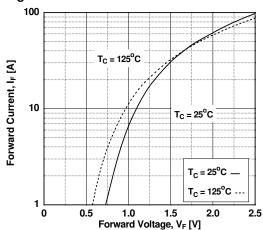


Figure 19. Reverse Recovery Current

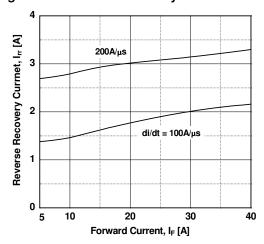


Figure 20. Stored Charge

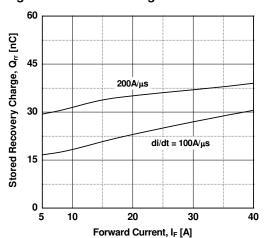


Figure 21. Reverse Recovery Time

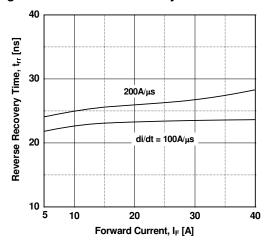
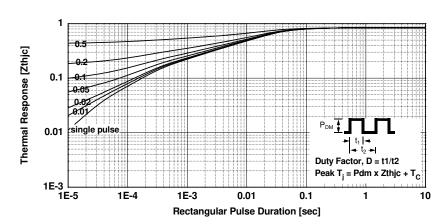


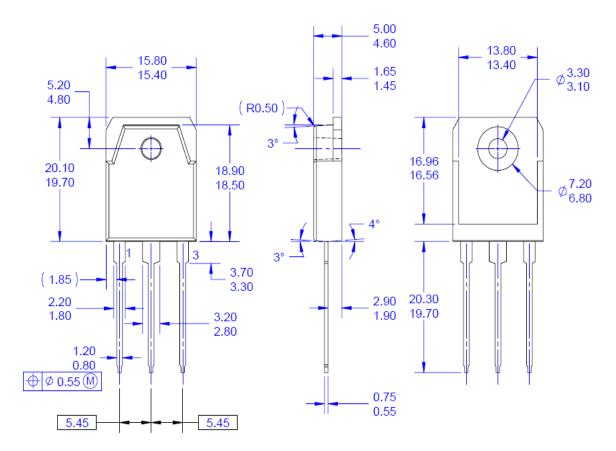
Figure 22.Transient Thermal Impedance of IGBT



#### **Mechanical Dimensions**

(R0.50)

TO-3PN



#### NOTES: UNLESS OTHERWISE SPECIFIED

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- B) ALL DIMENSIONS ARE IN MILLIMETERS.
- C) DIMENSION AND TOLERANCING PER ASME14.5
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- F) DRAWING FILE NAME: TO3P03AREV4.

Dimensions in Millimeters





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Preliminary	First Production	Datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.
No Identification Needed	Full Production	Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.
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